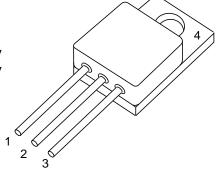
#### BUY25CS45B-01

#### **HiRel RadHard Power-MOS**

- Low R<sub>DS(on)</sub>
- Single Event Effect (SEE) hardened

 Total Ionisation Dose (TID) hardened 100 kRad approved

- Hermetically sealed
- N-channel



Туре	Marking	Pin Configuration				Pin Configuration Pac			Package
		1	2	3	4				
BUY25CS45B-01	-	D	S	G	Not connected	TO-254AA			

#### **Maximum Ratings**

Parameter	Symbol	Values	Unit
Drain Source Voltage	V <sub>DS</sub>	250	V
Gate Source Voltage	V <sub>GS</sub>	+/- 20	V
Drain Gate Voltage	$V_{DG}$	250	V
Continuous Drain Current $T_C = 25  ^{\circ}C$ $T_C = 100  ^{\circ}C$	I <sub>D</sub>	45 29	A
Continuous Source Current	Is	45	А
Drain Current Pulsed, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>DM</sub>	180	Apk
Total Power Dissipation 1)	P <sub>tot</sub>	208	W
Junction Temperature	TJ	-55 to + 150	°C
Operating and Storage Temperature	T <sub>op</sub>	-55 to + 150	°C
Avalanche Energy	E <sub>AS</sub>	380	mJ

#### **Thermal Characteristics**

Thermal Resistance (Junction to Case)	R <sub>th JC</sub>	0.6	K/W
Soldering Temperature	T <sub>sol</sub>	250	°C

#### Notes.:

1) For  $T_S \le 25^{\circ}$ C. For  $T_S > 25^{\circ}$ C derating is required.

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#### Data Sheet BUY25CS45B-01

Electrical Characteristics, at T<sub>A</sub>=25°C; unless otherwise specified

Parameter	Symbol	Va	alues	Unit
		min.	max.	
DC Characteristics		•	<u> </u>	
Breakdown Voltage Drain to Source $I_D = 0.25$ mA, $V_{GS} = 0$ V	B <sub>VDSS</sub>	250	-	V
Gate Threshold Voltage I <sub>D</sub> = 1.0mA, V <sub>DS</sub> ≥ V <sub>GS</sub>	$V_{GS(th)}$	2.0	4.0	V
Gate to Source Leakage Current V <sub>DS</sub> = 0V, V <sub>GS</sub> = +/- 20V	I <sub>GSS</sub>	-	+/-100	nA
Drain Current $V_{DS} = 200V, V_{GS} = 0V$	I <sub>DSS</sub>	-	25	μΑ
Drain Source On Resistance 1) V <sub>GS</sub> = 10V, I <sub>D</sub> = 29A	r <sub>DS(ON)</sub>	-	0.05	Ω
Source Drain Diode, Forward Voltage $^{1), 2)}$ $V_{GS} = 0V$ , $I_S = 45A$	V <sub>SD</sub>	-	1.4	V
AC Characteristics				
Turn-on Delay Time $V_{DD} = 50\% V_{DS}, I_D = 29A, R_G = 4.7\Omega$	t <sub>d(ON)</sub>	-	50	ns
Rise Time $V_{DD} = 50\% V_{DS}$ , $I_D = 29A$ , $R_G = 4.7\Omega$	t <sub>r</sub>	-	95	ns
Turn-off Delay Time $V_{DD} = 50\% V_{DS}$ , $I_D = 29A$ , $R_G = 4.7\Omega$	t <sub>d(OFF)</sub>	-	80	ns
Fall Time $V_{DD} = 50\% V_{DS}$ , $I_D = 29A$ , $R_G = 4.7\Omega$	t <sub>f</sub>	-	75	ns
Reverse Recovery Time $V_{DD} < 50\% V_{DS}$ , $I_D = 45A$	t <sub>rr</sub>	-	600	ns
Common Source Input Capacitance $V_{DS} = 100V$ , $V_{GS} = 0V$ , $f = 1.0MHz$	C <sub>iss</sub>	3.5	6.5	nF
Common Source Output Capacitance $V_{DS} = 100V$ , $V_{GS} = 0V$ , $f = 1.0MHz$	C <sub>oss</sub>	250	400	pF
Common Source Reverse Transfer Capacitance V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V, f = 1.0MHz	C <sub>rss</sub>	5	20	pF
Total Gate Charge $V_{DD} = 50\% V_{DS}, V_{GS} = 10V, I_D = 45A$	$Q_G$	-	100	nC

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Notes.:
1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.
2) Measured within 2.0 mm of case.



### BUY25CS45B-01

#### **Electrical Characteristics**

at T<sub>A</sub>=125°C; unless otherwise specified

Parameter	Symbol	Values		Unit	
		min.	max.		
DC Characteristics					
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	$V_{GS(th)}$	1.5	-	V	
Gate to Source Leakage Current $V_{DS} = 0V$ , $V_{GS} = +/-20V$	I <sub>GSS</sub>	-	+/-200	nA	
Drain Current V <sub>DS</sub> = 200V, V <sub>GS</sub> = 0V	I <sub>DSS</sub>	-	250	μΑ	
Drain Source On Resistance $^{1)}$ $V_{GS} = 10V$ , $I_D = 29A$	r <sub>DS(ON)</sub>	-	0.09	Ω	

#### **Electrical Characteristics**

at T<sub>A</sub>=-55°C; unless otherwise specified

Parameter	Symbol	Values		Unit	
		min.	max.		
DC Characteristics					
Gate Threshold Voltage I <sub>D</sub> = 1.0mA, V <sub>DS</sub> ≥ V <sub>GS</sub>	$V_{GS(th)}$	-	5.0	V	

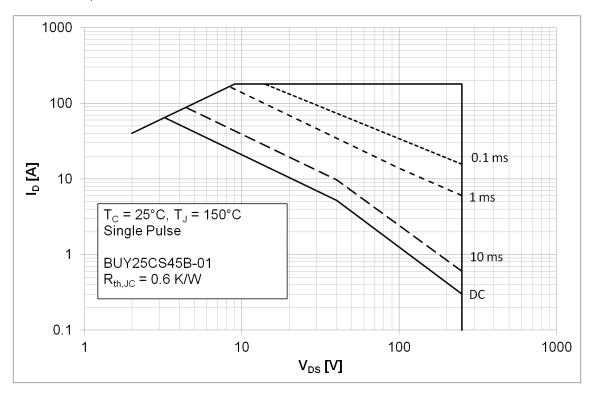
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Notes.:
1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.

### 1 Safe operating area

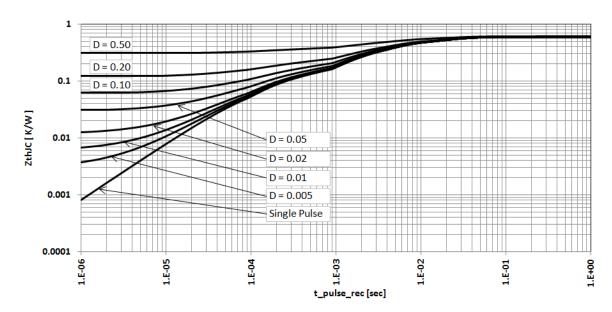
 $I_D = f(V_{DS}); T_C = 25^{\circ}C$ 

parameter: tp



#### 2 Max. transient thermal impedance

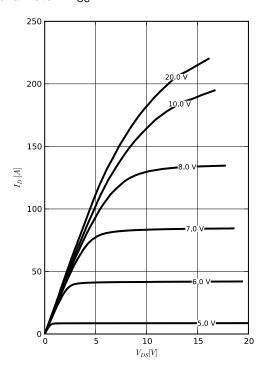
 $Z_{thJC} = f(t_p)$ parameter:  $D = t_p/T$ 



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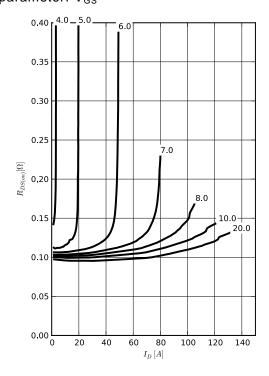
#### 3 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \text{ °C}$  parameter:  $V_{GS}$ 



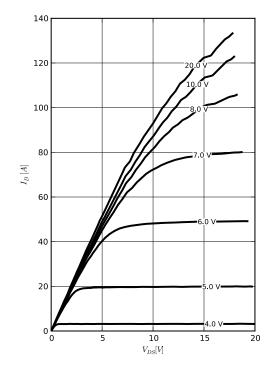
# 5 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 150 \text{ °C}$  parameter:  $V_{GS}$ 



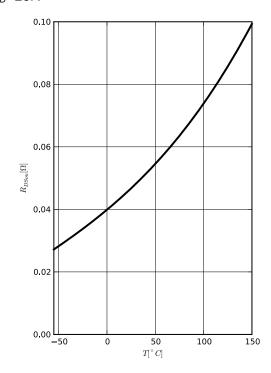
## 4 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 150 \text{ °C}$ parameter:  $V_G$ 



# 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j)$   $I_D = 29A$ 



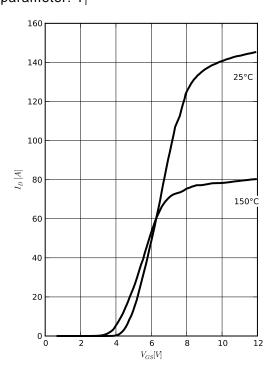
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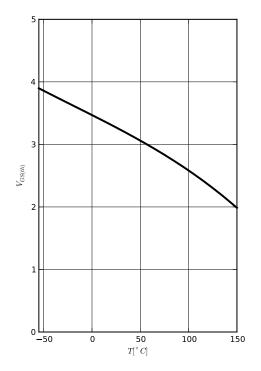
## 7 Typ. transfer characteristics

$$I_D = f(V_{GS}); |VDS| > 2 |I_D| R_{DS(on)max}$$
 parameter:  $T_i$ 



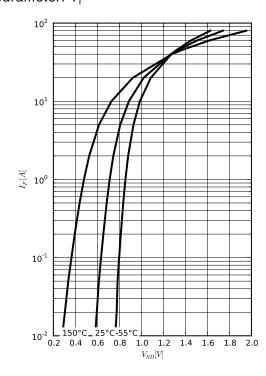
## 8 Typ. gate threshold voltage

$$I_D = f(T_j)$$
  
 $I_D = 1 \text{mA}$ 



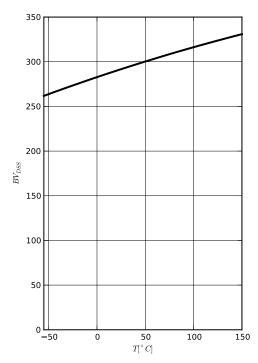
# 9 Typ. forward characteristics of reverse diode

$$I_F = f(V_{SD})$$
  
parameter:  $T_i$ 



# 10 Typ. drain-source breakdown voltage

$$BV_{DSS} = f(T_j)$$
  
 $I_D = 250\mu A$ 

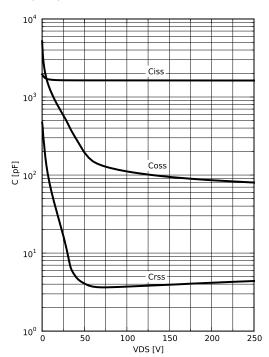




## BUY25CS45B-01

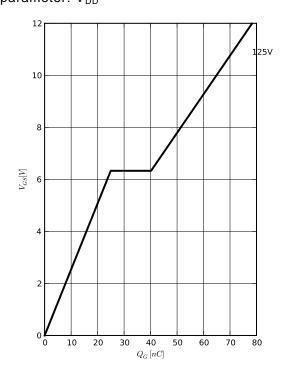
# 11 Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$

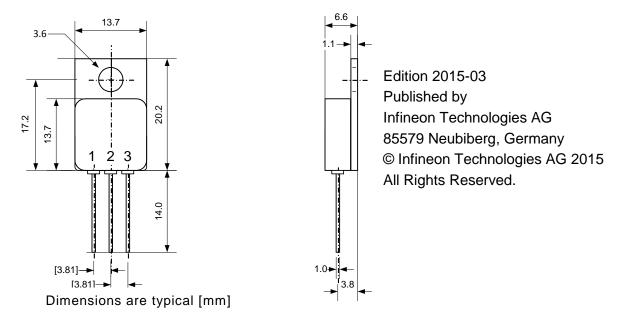


# 12 Typ. gate charge

$$V_{GS} = f(Q_{gate}); ID = 45.0 A pulsed parameter:  $V_{DD}$$$



### TO-254AA Package



#### Caution

This package contains beryllia. Therefore it must not be in any form machined, grinded, sanded, polished or any other mechanical operation which will produce dust and particles.

#### **Attention please!**

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